



AAT8307

20V P-Channel Power MOSFET

General Description

The AAT8307 is a low threshold P Channel MOSFET designed for the battery, cell phone, and PDA markets. Using AnalogicTech™'s proprietary ultra-high density Trench technology, and space saving small outline J-lead package, performance superior to that normally found in a larger footprint has been squeezed into the area of a TSOP6 package.

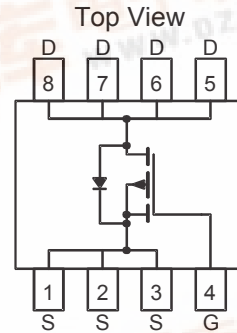
Features

- $V_{DS(MAX)} = -20V$
- $I_{D(MAX)}^1 = -6.0A @ 25^{\circ}C$
- LOW $R_{DS(ON)}$:
 - $35 m\Omega @ V_{GS} = -4.5V$
 - $60 m\Omega @ V_{GS} = -2.5V$

Applications

- Battery Packs
- Cellular & Cordless Telephones
- Battery-powered portable equipment
- Load Switches

TSOPJW-8 Package



Absolute Maximum Ratings ($T_A=25^{\circ}C$ unless otherwise noted)

Symbol	Description	Value	Units
V_{DS}	Drain-Source Voltage	-20	V
V_{GS}	Gate-Source Voltage	± 12	V
I_D	Continuous Drain Current @ $T_J=150^{\circ}C$ ¹	$T_A = 25^{\circ}C$	± 6.0
		$T_A = 70^{\circ}C$	± 4.8
I_{DM}	Pulsed Drain Current ²	± 32	A
I_S	Continuous Source Current (Source-Drain Diode) ¹	-1.9	A
P_D	Maximum Power Dissipation ¹	$T_A = 25^{\circ}C$	2.1
		$T_A = 70^{\circ}C$	1.3
T_J, T_{STG}	Operating Junction and Storage Temperature Range	-55 to 150	$^{\circ}C$

Thermal Characteristics

Symbol	Description	Typ	Max	Units
$R_{\theta JA}$	Junction-to-Ambient steady state ¹	90	110	$^{\circ}C/W$
$R_{\theta JA2}$	Junction-to-Ambient $t < 5$ seconds ¹	48	59	$^{\circ}C/W$
$R_{\theta JF}$	Junction-to-Foot ¹	31	37	$^{\circ}C/W$

Preliminary Information



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Description	Conditions	Min	Typ	Max	Units
DC Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =-250μA	-20			V
R _{DS(ON)}	Drain-Source ON-Resistance ²	V _{GS} =-4.5V, I _D =-6.0A		27	35	mΩ
		V _{GS} =-2.5V, I _D =-4.6A		46	60	
I _{D(ON)}	On-State Drain Current ²	V _{GS} =-4.5V, V _{DS} =-5V (Pulsed)	-32			A
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =-250μA	-0.6			V
I _{GSS}	Gate-Body Leakage Current	V _{GS} =±12V, V _{DS} =0V			±100	nA
I _{DSS}	Drain Source Leakage Current	V _{GS} =0V, V _{DS} =-20V			-1	μA
		V _{GS} =0V, V _{DS} =-16V, T _J =70°C ³			-5	
g _{fs}	Forward Transconductance ²	V _{DS} =-5V, I _D =-6.0A		12		S
Dynamic Characteristics ³						
Q _G	Total Gate Charge	V _{DS} =-15V, R _D =2.5Ω, V _{GS} =-4.5V		14		nC
Q _{GS}	Gate-Source Charge	V _{DS} =-15V, R _D =2.5Ω, V _{GS} =-4.5V		2.3		
Q _{GD}	Gate-Drain Charge	V _{DS} =-15V, R _D =2.5Ω, V _{GS} =-4.5V		5.5		
t _{D(ON)}	Turn-ON Delay	V _{DD} =-15V, V _{GS} =-4.5V, R _D =2.5Ω, R _G =6Ω		10		ns
t _R	Turn-ON Rise Time	V _{DD} =-15V, V _{GS} =-4.5V, R _D =2.5Ω, R _G =6Ω		37		
t _{D(OFF)}	Turn-OFF Delay	V _{DD} =-15V, V _{GS} =-4.5V, R _D =2.5Ω, R _G =6Ω		36		
t _F	Turn-OFF Fall Time	V _{DD} =-15V, V _{GS} =-4.5V, R _D =2.5Ω, R _G =6Ω		52		
Source-Drain Diode Characteristics						
V _{SD}	Source-Drain Forward Voltage ²	V _{GS} =0, I _S =-6.0A			-1.2	V
I _S	Continuous Diode Current ¹				-1.9	A

Note 1: Based on thermal dissipation from junction to ambient while mounted on a 1" x 1" PCB with optimized layout. A 5 second pulse on a 1" x 1" PCB approximates testing a device mounted on a large multi-layer PCB as in most applications. R_{θJF} + R_{θFA} = R_{θJA} where the foot thermal reference is defined as the normal solder mounting surface of the device's leads. R_{θJF} is guaranteed by design, however R_{θCA} is determined by the PCB design. Actual maximum continuous current is limited by the application's design.

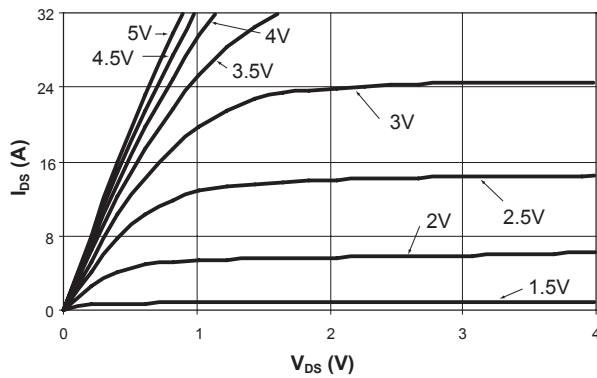
Note 2: Pulse test: Pulse Width = 300 μs

Note 3: Guaranteed by design. Not subject to production testing.

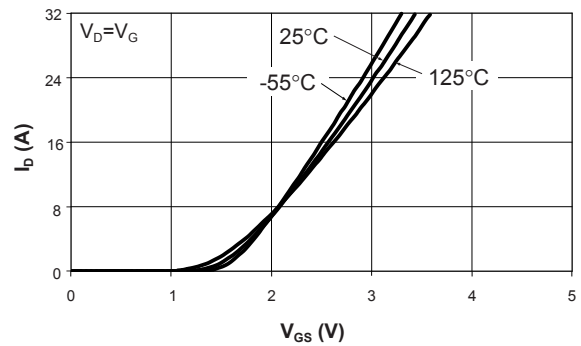
Typical Characteristics

($T_J = 25^\circ\text{C}$ unless otherwise noted)

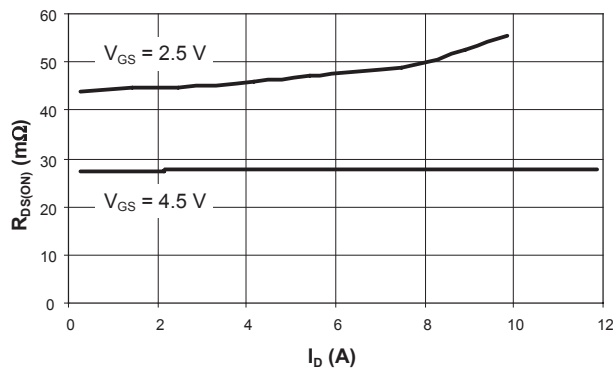
Output Characteristics



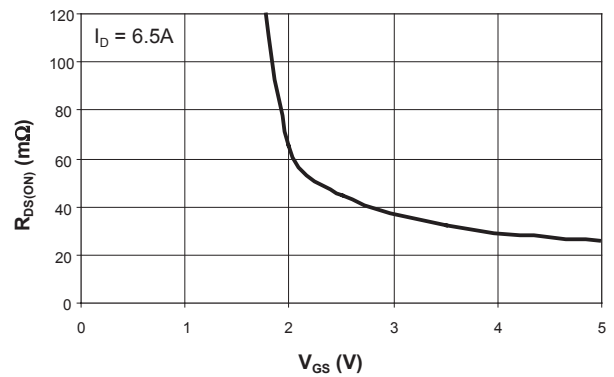
Transfer Characteristics



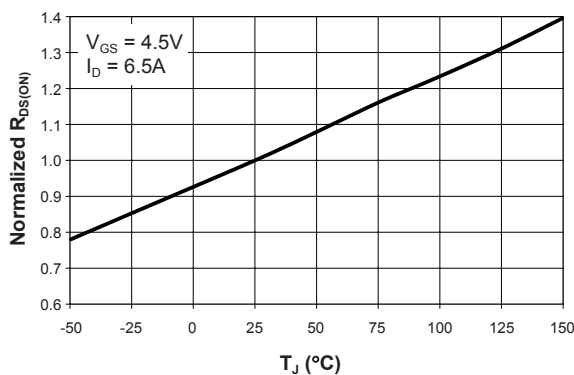
On-Resistance vs. Drain Current



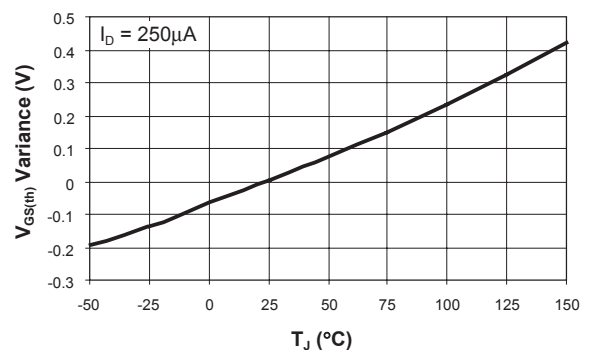
On-Resistance vs. Gate to Source Voltage



On-Resistance vs. Junction Temperature



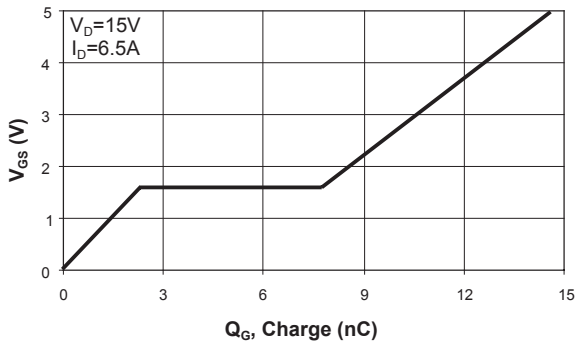
Threshold Voltage



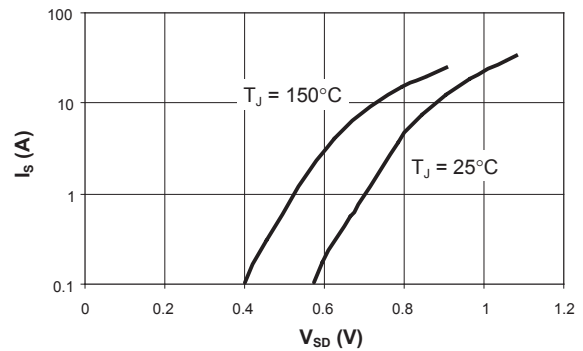
Typical Characteristics

($T_J = 25^\circ\text{C}$ unless otherwise noted)

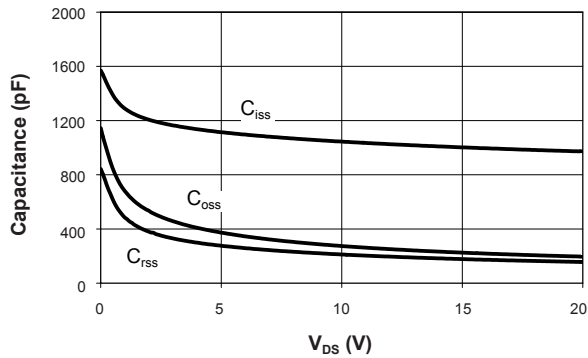
Gate Charge



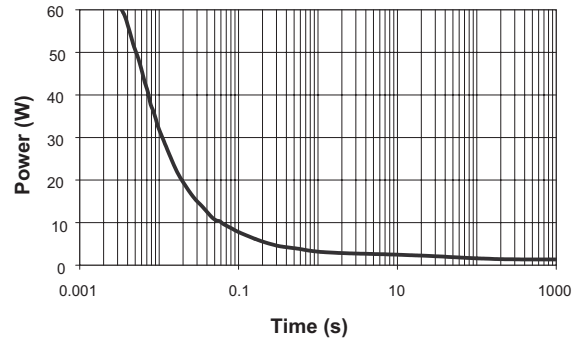
Source-Drain Diode Forward Voltage



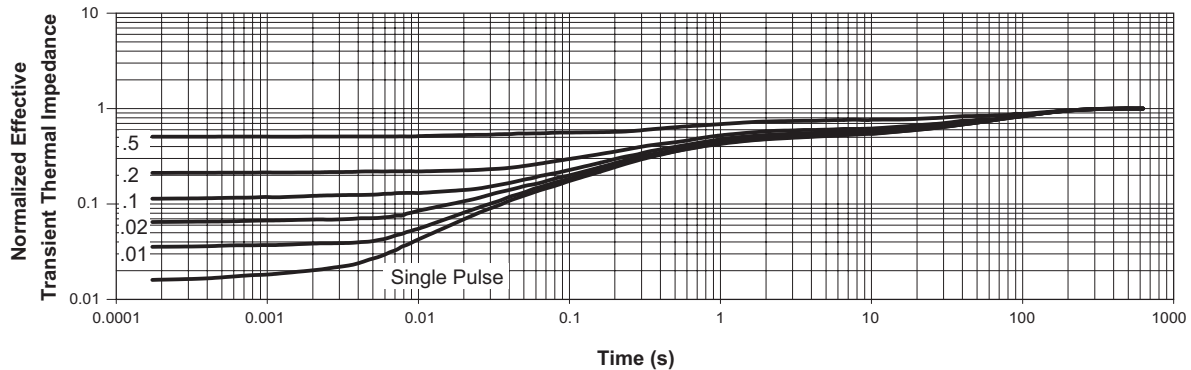
Capacitance



Single Pulse Power, Junction to Ambient



Transient Thermal Response, Junction to Ambient



Ordering Information

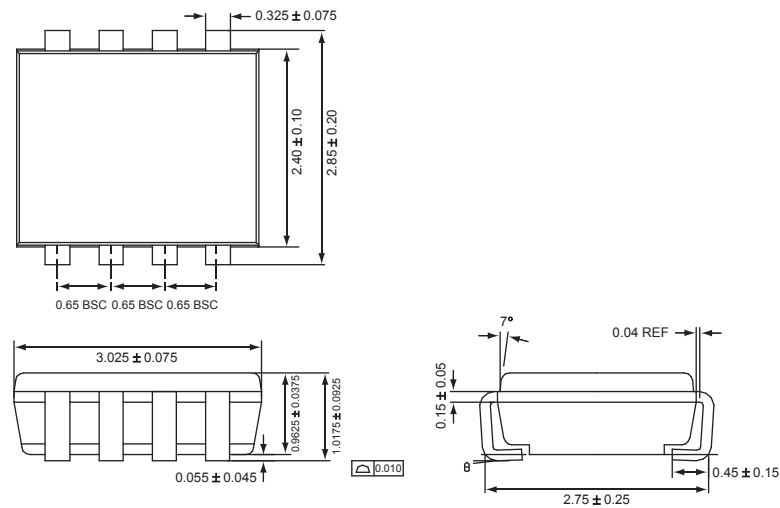
Package	Marking ¹	Part Number (Tape and Reel)
TSOPJW-8	ICXYY	AAT8307ITS-T1

Note: Sample stock is generally held on all part numbers listed in **BOLD**.

Note 1: XYY = assembly and date code.

Package Information

TSOPJW-8



All dimensions in millimeters.

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